

TCAN284x-Q1 Automotive CAN FD and LIN System Basis Chip (SBC) with Wake Inputs and High-side Switches

1 Features

- AEC-Q100 qualified for automotive applications
- Meets the requirements for CAN flexible data (FD) per ISO 11898-2:2024
- Local interconnect network (LIN) physical layer specification ISO/DIS 17987-4:2024 compliant and conforms to SAEJ2602 recommended practice for LIN
- **Functional Safety Quality-Managed**
- Simplifies system power management with up to three regulators
 - Low drop out (LDO) regulator supporting up to 250mA for 3.3V or 5V MCUs (VCC1)
 - Short-to-battery protected 5V LDO regulator supporting up to 200mA externally (VCC2)
 - Control of an external PNP transistor supporting up to 350mA at 1.8V, 2.5V, 3.3V or 5V (VEXCC)
- Multiple methods to wake from sleep mode
 - CAN and LIN bus wake up pattern (WUP)
 - Optional, CAN selective wake up frame (WUF) capability (partial networking)
 - Local wake up (LWU) via WAKE pins
 - Cyclic sensing wake up support with HSS4
 - Digital wake up using the SW pin
- Four high-side switches for loads up to 150mA
- Protection and Diagnostic Features
 - Timeout, window and Q&A watchdog support
 - Undervoltage (UV), overvoltage (OV) and short-circuit supervision on regulator outputs
 - Fail-safe output (LIMP)
 - UV supervision of VSUP and VHSS; OV supervision of VHSS
 - Advanced CAN bus fault diagnostics
 - $\pm 58V$ CAN bus fault tolerance
 - Integrated system level ESD protection
- Customer-accessible EEPROM to save device configuration
- QFN (32) package with improved automated optical inspection (AOI) capability

2 Applications

- **Body electronics and lighting**
- **Body Control Modules**
- **Infotainment and cluster**
- **Hybrid, electric and power train systems**
- **Industrial transportation**

3 Description

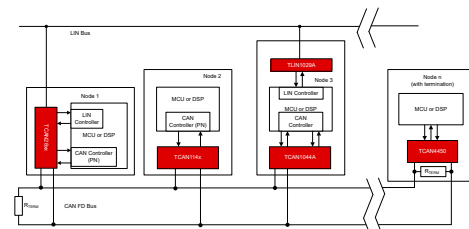
The TCAN284x-Q1 is a family of system basis chips (SBC) that provide a control area network flexible data rate capable (CAN FD) transceiver that supports selective wake. The TCAN2847x-Q1 includes a local interconnect network (LIN) transceiver. The CAN FD transceiver supports data rates up to 8Mbps while the LIN transceiver supports fast mode data rates up to 200kbps. The VCC1 LDO provides 3.3V or 5V $\pm 2\%$ with up to 250mA of current and determines the digital IO logic levels. If more current is needed, an external PNP transistor can be used to support up to 350mA and voltages of 1.8V, 2.5V, 3.3V or 5V. VCC2 LDO provides 5V up to 200mA.

The TCAN284x-Q1 includes features such as LIMP, three local wake inputs and four high side switches. The high side switch can be on/off, 10-bit PWM or timer controlled. Controlling an external CAN FD, LIN transceiver, CAN SBC or LIN SBC is possible using the GFO pin. The WAKE pins can be configured for static sensing, cyclic sensing (with HSS4 pin) and pulse based for waking up. These devices provide EEPROM to store specific device configuration information; thus, avoiding extensive reprogramming after power fluctuations. WAKE1 and WAKE2 can enable an internal switch between pins to enable external V_{BAT} monitoring. WAKE3 can be configured as a direct drive control pin for any combinations of high-side switches when cyclic sensing wake is enabled.

Package Information

PART NUMBER	PACKAGE ⁽¹⁾	PACKAGE SIZE ⁽²⁾
TCAN2845-Q1 TCAN2847-Q1	QFN (RHB, 32)	5mm x 5mm

- (1) For more information, see Mechanical, Packaging and Orderable Information.
- (2) The package size (length \times width) is a nominal value and includes pins, where applicable.



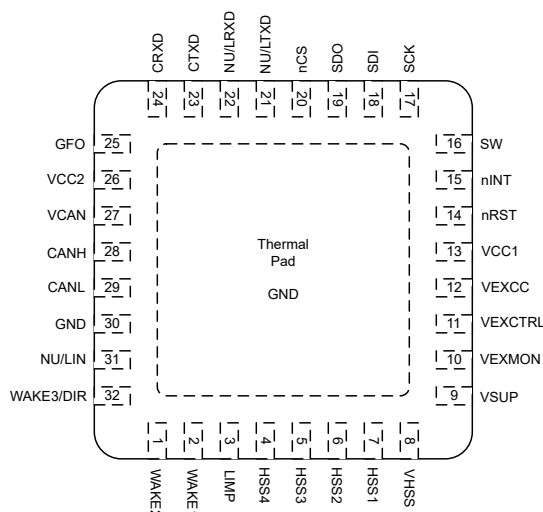
Simplified Schematic



4 Device Comparison Table

Device Number	CAN FD Transceiver	LIN Transceiver	Selective Wake	3.3V LDO	5V LDO
TCAN28453RHBQ1	X		X	X	
TCAN28455RHBQ1	X		X		X
TCAN28473RHBQ1	X	X	X	X	
TCAN28475RHBQ1	X	X	X		X

5 Pin Configuration and Functions



**Figure 5-1. RHB Package, 32 Pin (QFN)
Top View**

Table 5-1. Pin Functions RHB Package

NO.	PIN		TYPE	DESCRIPTION
	TCAN2845-Q1	TCAN2847-Q1		
1	WAKE2	WAKE2	high voltage	Local wake input terminal, high voltage capable
2	WAKE1	WAKE1	high voltage	Local wake input terminal, high voltage capable
3	LIMP	LIMP	high voltage	Limp home output (Active low; open-drain output)
4	HSS4	HSS4	high voltage	High side switch
5	HSS3	HSS3	high voltage	High side switch
6	HSS2	HSS2	high voltage	High side switch
7	HSS1	HSS1	high voltage	High side switch
8	VHSS	VHSS	power	High side switch power
9	VSUP	VSUP	high voltage power	High voltage supply from the battery
10	VEXMON	VEXMON	power	External PNP emitter connection, shunt connection. Connect to VSUP if external PNP LDO is not used. DO not leave floating.
11	VEXCTRL	VEXCTRL	power	External PNP base control
12	VEXCC	VEXCC	power	External PNP collector connection feedback
13	VCC1	VCC1	power	LDO supply output: 3.3V or 5V
14	nRST	nRST	digital	VCC output monitor pin (active low) and device reset input
15	nINT	nINT	digital	Interrupt output (active low)
16	SW	SW	digital	Programming mode input pin (SPI configurable active high or active low)
17	SCK	SCK	digital	SPI clock input
18	SDI	SDI	digital	SPI data input
19	SDO	SDO	digital	SPI data output
20	nCS	nCS	digital	Chip select input (active low)
21	NU	LTXD	digital	LIN transmit data input (low for dominant and high for recessive bus states). NU is not used and should not be connected to anything.
22	NU	LRXD	digital	LIN receive data output (low for dominant and high for recessive bus states), tri-state. NU is not used and should not be connected to anything.
23	CTXD	CTXD	digital	CAN transmit data input (low for dominant and high for recessive bus states).
24	CRXD	CRXD	digital	CAN receive data output (low for dominant and high for recessive bus states), tri-state.
25	GFO	GFO	digital	Function output pin (SPI configurable)
26	VCC2	VCC2	power	5V LDO output
27	VCAN	VCAN	power	CAN FD transceiver 5V power supply input
28	CANH	CANH	bus I/O	High level CAN bus I/O line

Table 5-1. Pin Functions RHB Package (continued)

NO.	PIN		TYPE	DESCRIPTION
	TCAN2845-Q1	TCAN2847-Q1		
29	CANL	CANL	bus I/O	Low level CAN bus I/O line
30	GND	GND	power	Ground connection: Must be soldered to ground
31	NU	LIN	high voltage I/O	LIN bus input/output pin: NU is not used and should not be connected to anything.
32	WAKE3/DIR	WAKE3/DIR	high voltage	Local wake input terminal, high voltage capable. Direct drive to control any HSSx when configured
PAD ⁽¹⁾	GND	GND	power	Ground connection: Must be soldered to ground

(1) The thermal pad, PAD, is a device ground pin must be soldered to GND

6 Device and Documentation Support

This device conforms to the following CAN standards. The core of what is needed is covered within this system spec, however reference should be made to these standards and any discrepancies pointed out and discussed. This document should provide all the basics of what is needed. However, for a full understanding of CAN including the protocol these additional sources are helpful as the scope of CAN protocol in detail is outside the scope of this physical layer (transceiver) specification.

6.1 Documentation Support

6.1.1 CAN Transceiver Physical Layer Standards:

- ISO 11898-2:2024: High speed medium access unit with low power mode (super sets -2 standard electrically in several specs and adds the original wake up capability via the bus in low power mode)
- ISO 8802-3: CSMA/CD – referenced for collision detection from ISO11898-2
- SAE J2284-2: High Speed CAN (HSC) for Vehicle Applications at 250 kbps
- SAE J2284-3: High Speed CAN (HSC) for Vehicle Applications at 500 kbps

6.1.2 LIN Transceiver Physical Layer Standards

- ISO/DIS 17987-1: Road vehicles -- Local Interconnect Network (LIN) -- Part 1: General information and use case definition
- ISO/DIS 17987-4: 2023 Road vehicles -- Local Interconnect Network (LIN) -- Part 4: Electrical Physical Layer (EPL) specification 12V
- SAEJ2602-1: LIN Network for Vehicle Applications
- LIN2.0, LIN2.1, LIN2.2 and LIN2.2A specification

6.1.3 EMC Requirements:

- SAEJ2962-2: US3 requirements for CAN Transceivers (-2, -5, GM will propose updates to address -6 + FD, but this is the best place for a working start)
- HW Requirements for CAN, LIN, FR V1.3: German OEM requirements for CAN and LIN
- ISO 10605: Road vehicles - Test methods for electrical disturbances from electrostatic discharge
- ISO 11452-4:2011: Road vehicles - Component test methods for electrical disturbances from narrowband radiated electromagnetic energy - Part 4: Harness excitation methods
- ISO 7637-1:2015: Road vehicles - Electrical disturbances from conduction and coupling - Part 1: Definitions and general considerations
- ISO 7637-3: Road vehicles - Electrical disturbances from conduction and coupling - Part 3: Electrical transient transmission by capacitive and inductive coupling via lines other than supply lines
- IEC 62132-4:2006: Integrated circuits - Measurement of electromagnetic immunity 150 kHz to 1 GHz - Part 4: Direct RF power injection method
- IEC 61000-4-2
- IEC 61967-4
- CISPR25

6.1.4 Conformance Test Requirements:

- HS_TRX_Test_Spec_V_1_0: GIFT / ICT CAN test requirements for High Speed Physical Layer
- ISO/DIS 17987-7: Road vehicles -- Local Interconnect Network (LIN) -- Part 7: Electrical Physical Layer (EPL) conformance test specification
- SAEJ2602-2: LIN Network for Vehicle Applications Conformance Test

6.1.5 Related Documentation

- "A Comprehensive Guide to Controller Area Network", Wilfried Voss, Copperhill Media Corporation
- "CAN System Engineering: From Theory to Practical Applications", 2nd Edition, 2013; Dr. Wolfhard Lawrenz, Springer.

6.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](https://www.ti.com). Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

6.3 Support Resources

TI E2E™ [support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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6.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

6.6 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

7 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision * (November 2024) to Revision A (May 2025)	Page
• Changed the document from Advanced Information to <i>Production</i> data.....	1

8 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
PTCAN28453RHBRQ1	Active	Preproduction	VQFN (RHB) 32	5000 LARGE T&R	-	Call TI	Call TI	-40 to 125	
PTCAN28453RHBRQ1.A	Active	Preproduction	VQFN (RHB) 32	5000 LARGE T&R	-	Call TI	Call TI	-40 to 125	
PTCAN28455RHBRQ1	Active	Preproduction	VQFN (RHB) 32	5000 LARGE T&R	-	Call TI	Call TI	-40 to 125	
PTCAN28455RHBRQ1.A	Active	Preproduction	VQFN (RHB) 32	5000 LARGE T&R	-	Call TI	Call TI	-40 to 125	
PTCAN28473RHBRQ1	Active	Preproduction	VQFN (RHB) 32	5000 LARGE T&R	-	Call TI	Call TI	-40 to 125	
PTCAN28473RHBRQ1.A	Active	Preproduction	VQFN (RHB) 32	5000 LARGE T&R	-	Call TI	Call TI	-40 to 125	
PTCAN28475RHBRQ1	Active	Preproduction	VQFN (RHB) 32	5000 LARGE T&R	-	Call TI	Call TI	-40 to 125	
PTCAN28475RHBRQ1.A	Active	Preproduction	VQFN (RHB) 32	5000 LARGE T&R	-	Call TI	Call TI	-40 to 125	
TCAN28453RHBRQ1	Active	Production	VQFN (RHB) 32	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TCAN 28453
TCAN28455RHBRQ1	Active	Production	VQFN (RHB) 32	5000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TCAN 28455
TCAN28473RHBRQ1	Active	Production	VQFN (RHB) 32	5000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TCAN 28473
TCAN28473RHBRQ1.A	Active	Production	VQFN (RHB) 32	5000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TCAN 28473
TCAN28475RHBRQ1	Active	Production	VQFN (RHB) 32	5000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TCAN 28475
TCAN28475RHBRQ1.A	Active	Production	VQFN (RHB) 32	5000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TCAN 28475

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TCAN28453RHBRQ1	VQFN	RHB	32	3000	330.0	12.4	5.3	5.3	1.1	8.0	12.0	Q2
TCAN28455RHBRQ1	VQFN	RHB	32	5000	330.0	12.4	5.3	5.3	1.1	8.0	12.0	Q2
TCAN28473RHBRQ1	VQFN	RHB	32	5000	330.0	12.4	5.3	5.3	1.1	8.0	12.0	Q2
TCAN28475RHBRQ1	VQFN	RHB	32	5000	330.0	12.4	5.3	5.3	1.1	8.0	12.0	Q2

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TCAN28453RHBRQ1	VQFN	RHB	32	3000	367.0	367.0	35.0
TCAN28455RHBRQ1	VQFN	RHB	32	5000	367.0	367.0	35.0
TCAN28473RHBRQ1	VQFN	RHB	32	5000	367.0	367.0	35.0
TCAN28475RHBRQ1	VQFN	RHB	32	5000	367.0	367.0	35.0

GENERIC PACKAGE VIEW

RHB 32

VQFN - 1 mm max height

5 x 5, 0.5 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD



Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

4224745/A



VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



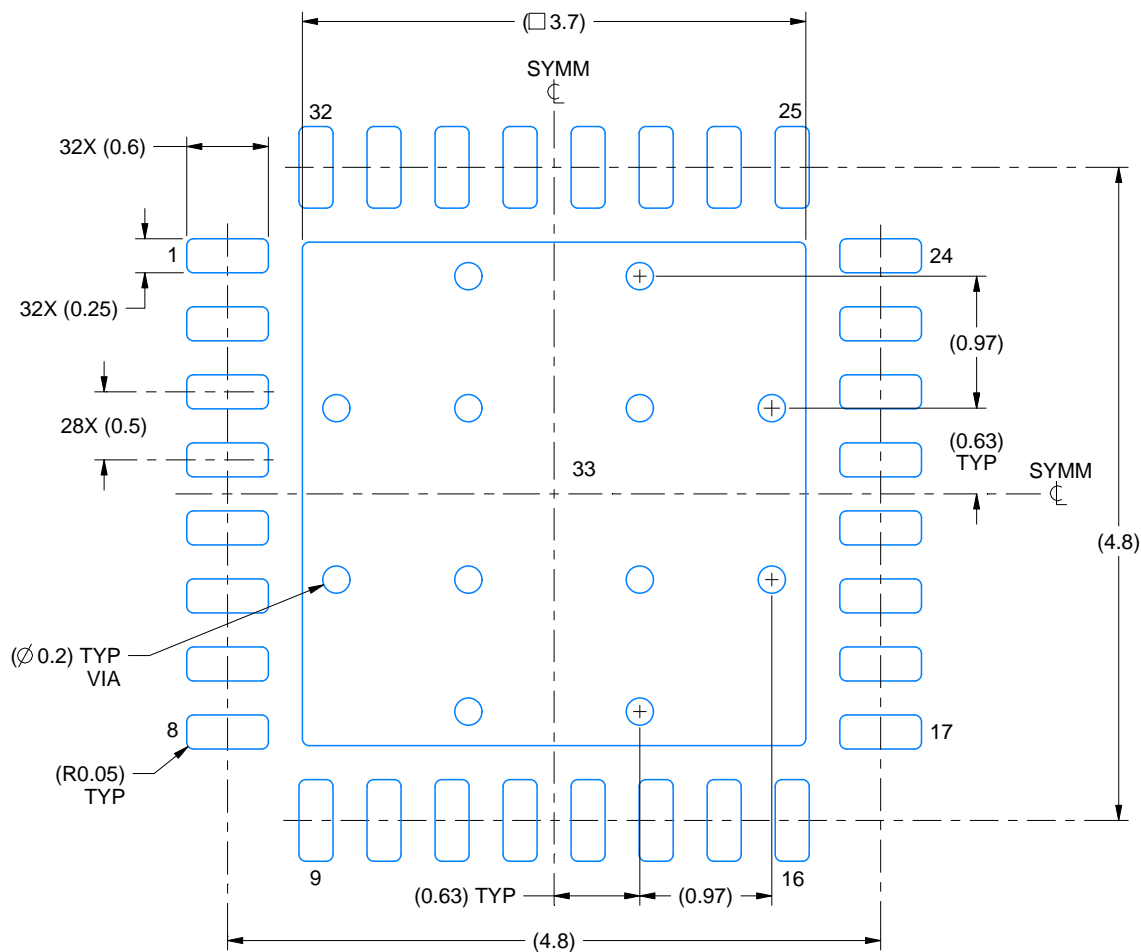
NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

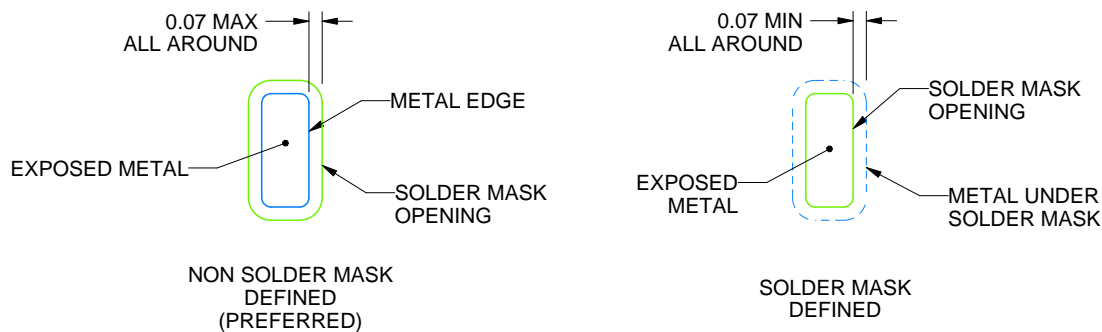
RHB0032U

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:18X



SOLDER MASK DETAILS

4225709/C 01/2021

NOTES: (continued)

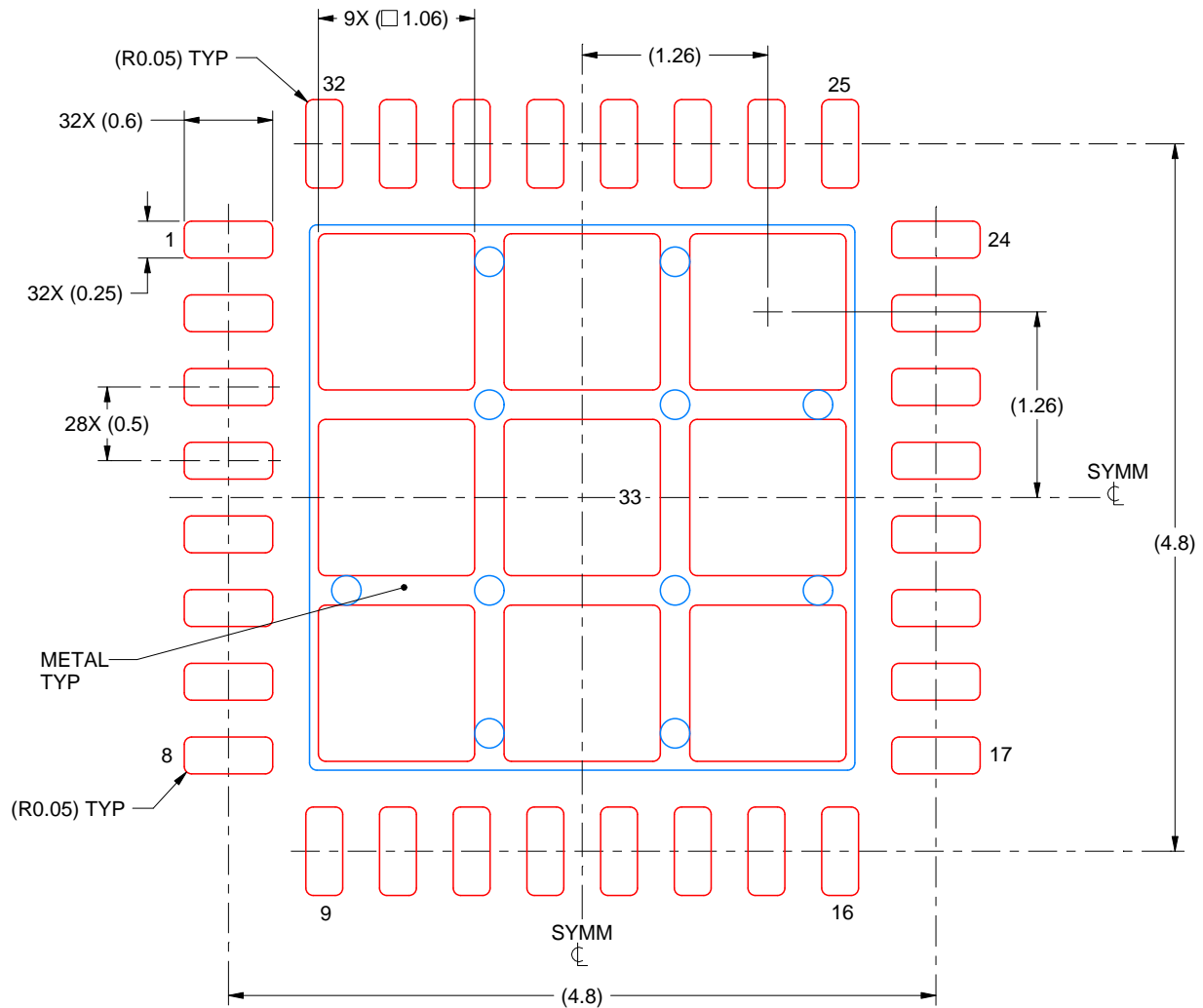
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/sluea271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE STENCIL DESIGN

RHB0032U

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 33:
74% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE
SCALE:20X

4225709/C 01/2021

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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